

Search Notes

Application/Control No.

10/724,729

Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination

UMEHARA ET AL.

Art Unit

2821

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|---|-----------|----------|
| 343 | 700MS, 702, 725, 815, 817, 846 | 7/11/2005 | CHEN |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------|-----------|------|
| EAST (See attached printout). | 7/11/2005 | CHEN |
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